

Notice of References Cited

Application/Control No.

10/065,225

Applicant(s)/Patent Under
Reexamination
BECK ET AL.

Examiner

John P. Sheehan

Art Unit

1742

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-4,981,644	01-1991	Chang, Keh-Minn	420/442
	C	US-4,219,592	08-1980	Anderson et al.	427/405
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	N	61-73853	04-1986	Japan	Abeyama et al.	420/448
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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